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PATENT NUMBER

U.S. **UTILITY** Patent Application

	O.I.P.E.
5/1020	SCANNED ENL O.A. TM

PATENT DATE

APPLICATION NO.	CONT/PRIOR	CLASS	SUBCLASS	ART UNIT	EXAMINER
09/849707	D	361	9 9	2836	H22112

PPLICANTS

Gregory Smith Donald Archer John Oglesbee Parr. Hausen

Apparatus and method for improving ESD and transient immunity in shunt regulators

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ORIGINAL		CROSS	REFERENCE(S)	سنت م	
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TERMINAL DISCLAIMER	DRAWINGS			CLAIMS ALLOWED		
	Sheets Drwg.	Figs. Drwg.	Print Fig.	Total Claims	Print Claim for O.G	
The term of this patent subsequent to (date) has been disclaimed.	(Assistant F	Examiner)	(Date)	NOTICE OF ALL	OWANCE MAILED	
The term of this patent shall not extend beyond the expiration date of U.S Patent: No.	(Letta)		/ ISSUE FEE			
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